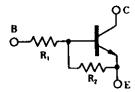


# FB1 SERIES

## on-chip resistor NPN silicon epitaxial transistor For mid-speed switching

#### **FEATURES**

- Up to 0.7 A current drive available
- · On-chip bias resistor
- · Low power consumption during drive



### QUALITY GRADES

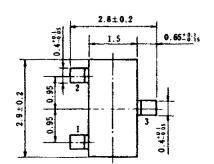
Standard

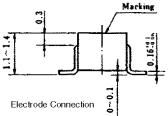
Please refer to "Quality Grades on NEC Semiconductor Devices" (Document No. C11531E) published by NEC Corporation to know the specification of quality grade on the devices and its recommended applications.

### **FB1 SERIES LISTS**

Products	Marking	R <sub>1</sub> (KΩ)	R <sub>2</sub> (KΩ)
FB1A4A	P30	-	10
FB1L2Q	P31	0.47	4.7
FB1A3M	P32	1.0	1.0
FB1F3P	P33	2.2	10
FB1J3P	P36	3.3	10
FB1L3N	P34	4.7	10
FB1A4M	P35	10	10

### PACKAGE DRAWING (UNIT: mm)





- 1. Emitter (E)
- 2. Base (B) 3. Collector (C)

### ABSOLUTE MAXIMUM RATINGS (Ta = 25°C)

Parameter	Symbol	Ratings	Unit
Collector to base voltage	VcBo	30	V
Collector to emitter voltage	VCEO	25	V
Emitter to base voltage	VEBO	10	V
Collector current (DC)	Ic(DC)	0.7	Α
Collector current (Pulse)	C(pulse) *	1.0	Α
Base current (DC)	I <sub>B(DC)</sub>	20	mA
Total power dissipation	Рт	200	mW
Junction temperature	Tj	150	°C
Storage temperature	T <sub>stg</sub>	-55 to +150	°C

<sup>\*</sup> PW≤10 ms, duty cycle≤50 %

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# FB1A4A ELECTRICAL CHARACTERISTICS (Ta = 25°C)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Collector cutoff current	Ісво	V <sub>CB</sub> = 30 V, I <sub>E</sub> = 0			100	nA
DC current gain	h <sub>FE1</sub> **	Vce = 2.0 V, Ic = 0.1 A	300			-
DC current gain	hFE2 **	Vce = 2.0 V, Ic = 0.5 A	300			-
DC current gain	h <sub>FE3</sub> **	Vce = 2.0 V, Ic = 0.7 A	135			-
Collector saturation voltage	V <sub>CE(sat)</sub> **	Ic = 0.5 A, I <sub>B</sub> = 5 mA		0.27	0.4	V
Low level input voltage	VIL **	$V_{CE} = 5.0 \text{ V}, \text{ Ic} = 100 \ \mu\text{A}$			0.3	V
Input resistance	R <sub>1</sub>		-	_	-	Ω
E-to-B resistance	R <sub>2</sub>		7	10	13	kΩ

<sup>\*\*</sup> PW  $\leq$  350  $\mu$ s, duty cycle  $\leq$  2 %

### FB1L2Q ELECTRICAL CHARACTERISTICS (Ta = 25°C)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Collector cutoff current	Ісво	V <sub>CB</sub> = 30 V, I <sub>E</sub> = 0			100	nA
DC current gain	h <sub>FE1</sub> **	VcE = 2.0 V, Ic = 0.1 A	150	400		-
DC current gain	hFE2 **	Vce = 2.0 V, Ic = 0.5 A	300	700		-
DC current gain	h <sub>FE3</sub> **	Vce = 2.0 V, Ic = 0.7 A	135	600		-
Low level output voltage	Vol **	V <sub>IN</sub> = 5.0 V, Ic = 0.5 A		0.2	0.3	V
Low level input voltage	VIL **	$V_{CE} = 5.0 \text{ V}, \text{ Ic} = 100 \ \mu\text{A}$		0.62	0.3	V
Input resistance	R <sub>1</sub>		329	470	611	Ω
E-to-B resistance	R <sub>2</sub>		3.29	4.7	6.11	kΩ

<sup>\*\*</sup> PW  $\leq$  350  $\mu$ s, duty cycle  $\leq$  2 %

### FB1A3M ELECTRICAL CHARACTERISTICS (Ta = 25°C)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Collector cutoff current	Ісво	Vcb = 30 V, IE = 0			100	nA
DC current gain	h <sub>FE1</sub> **	Vce = 2.0 V, Ic = 0.1 A	80			-
DC current gain	h <sub>FE2</sub> **	Vce = 2.0 V, Ic = 0.5 A	100			-
DC current gain	h <sub>FE3</sub> **	Vce = 2.0 V, Ic = 0.7 A	135			-
Low level output voltage	Vol **	V <sub>IN</sub> = 5.0 V, Ic = 0.5 A		0.3	0.4	V
Low level input voltage	VIL **	$V_{CE} = 5.0 \text{ V}, \text{ Ic} = 100 \ \mu\text{A}$			0.3	V
Input resistance	R <sub>1</sub>		0.7	1.0	1.3	kΩ
E-to-B resistance	R <sub>2</sub>		0.7	1.0	1.3	kΩ

<sup>\*\*</sup> PW  $\leq$  350  $\mu$ s, duty cycle  $\leq$  2 %



FB1F3P ELECTRICAL CHARACTERISTICS (Ta = 25°C)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Collector cutoff current	Ісво	Vcb = 30 V, IE = 0			100	nA
DC current gain	hFE1 **	Vce = 2.0 V, Ic = 0.1 A	300			-
DC current gain	h <sub>FE2</sub> **	Vce = 2.0 V, Ic = 0.5 A	300			_
DC current gain	h <sub>FE3</sub> **	Vce = 2.0 V, Ic = 0.7 A	135			_
Low level output voltage	<b>V</b> ol **	$V_{IN} = 5.0 \text{ V}, \text{ Ic} = 0.3 \text{ A}$			0.3	V
Low level input voltage	VIL **	$V_{CE} = 5.0 \text{ V}, \text{ Ic} = 100 \ \mu\text{A}$			0.3	V
Input resistance	R <sub>1</sub>		1.54	2.2	2.86	kΩ
E-to-B resistance	R <sub>2</sub>		7	10	13	kΩ

<sup>\*\*</sup> PW  $\leq$  350  $\mu$ s, duty cycle  $\leq$  2 %

FB1J3P ELECTRICAL CHARACTERISTICS (Ta = 25°C)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Collector cutoff current	Ісво	Vcb = 30 V, IE = 0			100	nA
DC current gain	h <sub>FE1</sub> **	Vce = 2.0 V, Ic = 0.1 A	300	600		_
DC current gain	hFE2 **	Vce = 2.0 V, Ic = 0.5 A	300	700		_
DC current gain	h <sub>FE3</sub> **	Vce = 2.0 V, Ic = 0.7 A	135	600		-
Low level output voltage	<b>V</b> ol **	V <sub>IN</sub> = 5.0 V, Ic = 0.2 A		0.14	0.3	V
Low level input voltage	VIL **	$V_{CE} = 5.0 \text{ V}, \text{ Ic} = 100 \ \mu\text{A}$		0.6	0.3	V
Input resistance	R <sub>1</sub>		2.31	3.3	4.29	kΩ
E-to-B resistance	R <sub>2</sub>		7	10	13	kΩ

<sup>\*\*</sup> PW  $\leq$  350  $\mu$ s, duty cycle  $\leq$  2 %

FB1L3N ELECTRICAL CHARACTERISTICS (Ta = 25°C)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Collector cutoff current	Ісво	Vcb = 30 V, IE = 0			100	nA
DC current gain	h <sub>FE1</sub> **	Vce = 2.0 V, Ic = 0.1 A	300			-
DC current gain	hFE2 **	Vce = 2.0 V, Ic = 0.5 A	300			-
DC current gain	h <sub>FE3</sub> **	Vce = 2.0 V, Ic = 0.7 A	135			-
Low level output voltage	<b>V</b> ol **	V <sub>IN</sub> = 5.0 V, Ic = 0.2 A			0.3	V
Low level input voltage	VIL **	$V_{CE} = 5.0 \text{ V}, \text{ Ic} = 100 \ \mu\text{A}$			0.3	V
Input resistance	R <sub>1</sub>		3.29	4.7	6.11	kΩ
E-to-B resistance	R <sub>2</sub>		7	10	13	kΩ

<sup>\*\*</sup> PW  $\leq$  350  $\mu$ s, duty cycle  $\leq$  2 %



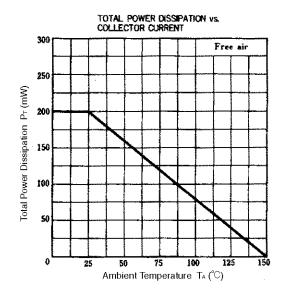
# FB1A4M ELECTRICAL CHARACTERISTICS (Ta = 25°C)

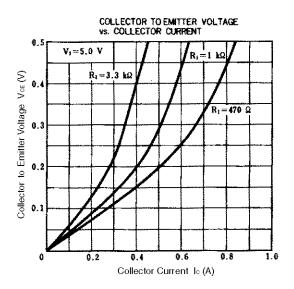
Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Collector cutoff current	Ісво	V <sub>CB</sub> = 30 V, I <sub>E</sub> = 0			100	nA
DC current gain	h <sub>FE1</sub> **	Vce = 2.0 V, Ic = 0.1 A	300			-
DC current gain	h <sub>FE2</sub> **	Vce = 2.0 V, Ic = 0.5 A	300			-
DC current gain	h <sub>FE3</sub> **	Vce = 2.0 V, Ic = 0.7 A	135			-
Collector saturation voltage	V <sub>CE(sat)</sub> **	$V_{IN} = 5.0 \text{ V}, \text{ Ic} = 0.2 \text{ A}$			0.3	V
Low level input voltage	VIL **	$V_{CE} = 5.0 \text{ V}, \text{ Ic} = 100 \ \mu\text{A}$			0.3	V
Input resistance	R <sub>1</sub>		7	10	13	kΩ
E-to-B resistance	R <sub>2</sub>		7	10	13	kΩ

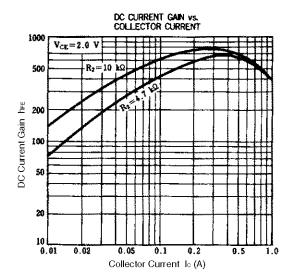
<sup>\*\*</sup> PW  $\leq$  350  $\mu$ s, duty cycle  $\leq$  2 %

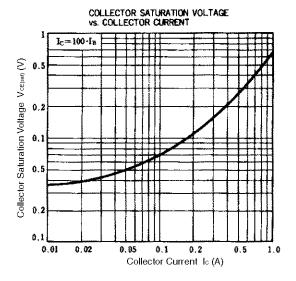


### TYPICAL CHARACTERISTICS (Ta = 25°C)











### RECOMMENDED SOLDERING CONDITIONS

This product should be soldered and mounted under the following recommended conditions.

For soldering methods and conditions other than those recommended below, contact an NEC sales representative.

#### **Surface MOUNTING TYPE**

For details of the recommended soldering conditions, refer to the document Semiconductor Device Mounting Technology Manual (C10535E).

Soldering Method	Soldering Conditions	Recommended Condition Symbol
Infrared reflow	Package peak temperature: 230°C, Time: 30 sec. max. (at 210°C or higher), Count: Once, Exposure limit: None *	IR30-00
VPS	Package peak temperature: 215°C, Time: 40 sec. max. (at 200°C or higher), Count: Once, Exposure limit: None *	VP15-00
Partial heating	Pin temperature: 300°C max., Time: 10 sec. max. Exposure limit: None *	0

<sup>\*</sup> After opening the dry pack, store it at 25°C or less and 65% RH or less for the allowable storage period.

Cautions 1. Do not use different soldering methods together (except for partial heating).

2. Prevent the resin surface temperature from being higher than the board temperature by 20°C or more.



[MEMO]

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